

**Notice of References Cited**

Application/Control No.

10/001,544

Applicant(s)/Patent Under  
Reexamination  
GREIL ET AL.

Examiner

Mark L. Berch

Art Unit

1624

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,489,470	12-2002	Greil et al.	540/220
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	U	
	V	
	W	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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